


<b>Search Notes</b> 	<b>Application/Control No.</b> 10581715	<b>Applicant(s)/Patent Under Reexamination</b> LEE, HYE-JIN
	<b>Examiner</b> HONG MEHTA	<b>Art Unit</b> 1794

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
east search- see atached	5/6/09	JH
Internet search	5/6/09	JH
Consutation with Tony weier	5/6/09	JH
Inventor search	5/6/09	JH
SIPO search	5/8/09	JH
Plus Search	5/6/09	JH
426/298, 299, 300, 301, 614- text limited	5/6/09	JH
206/320-text limited	5/6/09	JH
Updated EAST search	11/20/09	htm
Updated EAST serach	07/20-21/10	htm
Updated EAST search	10/29/2010	htm

INTERFERENCE SEARCH			
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